

# Computational Statistics

## Lecture 6: Two distributions, are they of the same kind ?

Raymond Bisdorff

University of Luxembourg

29 novembre 2019



## Content of Lecture 6

### 1. Methodology

Comparing statistical distributions

Methodological approach

Statistical tests

### 2. Comparing histograms

Chi-square test against a known distribution

Comparing two binned data sets

Testing uniform randomness

### 3. Comparing continuous distributions

Kolmogorov-Smirnov Test

Kolmogorov-Smirnov Test in R

## Comparing statistical distributions

- Given two sequences of random numbers, we can ask the question : *“Are the two sequences drawn from a same random number generator, or from different generators ?”*
- In proper statistical terms : *“Can we disprove, to a certain required level of significance that two data sets are drawn from the same population distribution function ?”*
- Disproving the null hypothesis proves that the data are from different random distributions.
- Failing to disprove, on the other hand, only shows that the data sets appear to be consistent with being generated from a same distribution function.

## Comparing statistical distributions

- Given two sequences of random numbers, we can ask the question : *“Are the two sequences drawn from a same random number generator, or from different generators ?”*
- In proper statistical terms : *“Can we disprove, to a certain required level of significance that two data sets are drawn from the same population distribution function ?”*
- Disproving the null hypothesis proves that the data are from different random distributions.
- Failing to disprove, on the other hand, only shows that the data sets appear to be consistent with being generated from a same distribution function.

## Comparing statistical distributions

- Given two sequences of random numbers, we can ask the question : *“Are the two sequences drawn from a same random number generator, or from different generators ?”*
- In proper statistical terms : *“Can we disprove, to a certain required level of significance that two data sets are drawn from the same population distribution function ?”*
- Disproving the null hypothesis proves that the data are from different random distributions.
- Failing to disprove, on the othe hand, only shows that the data sets appear to be consistent with being generated from a same distribution function.

## Comparing statistical distributions

- Given two sequences of random numbers, we can ask the question : *“Are the two sequences drawn from a same random number generator, or from different generators ?”*
- In proper statistical terms : *“Can we disprove, to a certain required level of significance that two data sets are drawn from the same population distribution function ?”*
- Disproving the null hypothesis proves that the data are from different random distributions.
- Failing to disprove, on the othe hand, only shows that the data sets appear to be consistent with being generated from a same distribution function.

# Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :

1.1 continuous, or

1.2 binned.

2. We wish to compare either

2.1 one data set with a known distribution,

2.2 two equally unknown data sets.

# Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :

1.1 continuous, or

1.2 binned.

2. We wish to compare either

2.1 one data set to a known distribution

2.2 two equally unknown data sets.



## Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :

1.1 continuous, or

1.2 binned.

2. We wish to compare either

2.1 one data set to a known distribution, or

2.2 two equally unknown data sets.

## Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :

1.1 continuous, or

1.2 binned.

2. We wish to compare either

2.1 one data set to a known distribution, or

2.2 two equally unknown data sets.

## Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :
  - 1.1 continuous, or
  - 1.2 binned.
2. We wish to compare either
  - 2.1 one data set to a known distribution, or
  - 2.2 two equally unknown data sets.

## Methodological approach

Four problems may appear from two dichotomies :

1. The data are either :
  - 1.1 continuous, or
  - 1.2 binned.
2. We wish to compare either
  - 2.1 one data set to a known distribution, or
  - 2.2 two equally unknown data sets.

## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov** test.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are not truthful per se. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.

## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov test**.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are not truthful per se. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.

## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov** test.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are not truthful per se. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.

## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov** test.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are **not truthful per se**. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.



## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov** test.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are **not truthful per se**. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.

## Statistical tests

- The usual test for differences between binned data is the **Chi-square goodness-of-fit test**.
- For continuous data as a function of a single variable, the usual test is the **Kolmogorov-Smirnov** test.
- One can always turn continuous data into binned data, by grouping the observed data into specified ranges of the continuous variable(s).
- There is however often some arbitrariness as how the bins should be chosen ; how many bins, with equal sizes or not ?
- Furthermore, binning always involves some loss of information. Even more, when uniform distributions of observations are not verified within all bins.
- Mind that statistical summaries are **not truthful per se**. They are merely numerical or graphical arguments supporting one or the other hypothesis concerning the observed data.

## 1. Methodology

Comparing statistical distributions

Methodological approach

Statistical tests

## 2. Comparing histograms

Chi-square test against a known distribution

Comparing two binned data sets

Testing uniform randomness

## 3. Comparing continuous distributions

Kolmogorov-Smirnov Test

Kolmogorov-Smirnov Test in R

## Chi-square test against a known distribution

- Consider a random sequence grouped into  $v$  bins.
- Suppose that  $N_i$  is the number of events observed in the  $i$ th bin, and that  $n_i$  is the number of expected events according to some known distribution. Note that the  $N_i$ 's are integers, while the  $n_i$ 's may not be.
- Then the Chi-square “*goodness-of-fit*” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(N_i - n_i)^2}{n_i}$$

where the sum runs over all  $v$  bins.

- A value of  $\chi^2 \gg v$  indicates that a “*goodness-of-fit*” is rather unlikely.

## Chi-square test against a known distribution

- Consider a random sequence grouped into  $v$  bins.
- Suppose that  $N_i$  is the number of events observed in the  $i$ th bin, and that  $n_i$  is the number of expected events according to some known distribution. Note that the  $N_i$ 's are integers, while the  $n_i$ 's may not be.
- Then the Chi-square “goodness-of-fit” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(N_i - n_i)^2}{n_i}$$

where the sum runs over all  $v$  bins.

- A value of  $\chi^2 \gg v$  indicates that a “goodness-of-fit” is rather unlikely.

## Chi-square test against a known distribution

- Consider a random sequence grouped into  $v$  bins.
- Suppose that  $N_i$  is the number of events observed in the  $i$ th bin, and that  $n_i$  is the number of expected events according to some known distribution. Note that the  $N_i$ 's are integers, while the  $n_i$ 's may not be.
- Then the Chi-square “*goodness-of-fit*” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(N_i - n_i)^2}{n_i}$$

where the sum runs over all  $v$  bins.

- A value of  $\chi^2 \gg v$  indicates that a “*goodness-of-fit*” is rather unlikely.

## Chi-square test against a known distribution

- Consider a random sequence grouped into  $v$  bins.
- Suppose that  $N_i$  is the number of events observed in the  $i$ th bin, and that  $n_i$  is the number of expected events according to some known distribution. Note that the  $N_i$ 's are integers, while the  $n_i$ 's may not be.
- Then the Chi-square “*goodness-of-fit*” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(N_i - n_i)^2}{n_i}$$

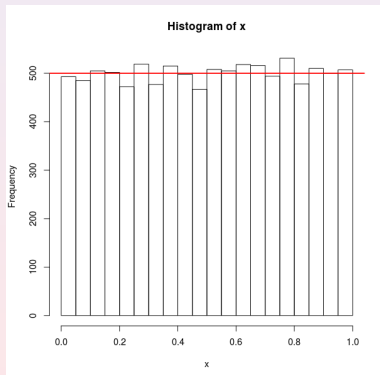
where the sum runs over all  $v$  bins.

- A value of  $\chi^2 \gg v$  indicates that a “*goodness-of-fit*” is rather *unlikely*.

# Uniformity Chi-Square *goodness-of-fit* Test in R

Let us test if the R `runif` generator is giving consistent data with a uniform distribution. The R `chisq.test` method implements this *goodness-of-fit* test.

```
> nSim = 10^4
> x = runif(nSim)
> freq = hist(x)
> Ni = freq$counts
> epsilon = length(Ni)
[1] 20
> ni = rep(nSim/epsilon,epsilon)
> chi2 = sum((Ni-ni)^2/ni)
[1] 18.4988
> df = epsilon - 1
> pvalue = 1.0 - pchisq(chi2,df)
[1] 0.4893842
> chisq.test(Ni)
X-squared = 18.4988 df = 19
p-value = 0.4893842
```





## Chi-square Test – continue

- Any term  $i$  with  $0 = n_i = N_i$  should be omitted from the sum.
- A term with  $n_i = 0$  and  $N_i \neq 0$  gives an infinite  $\chi^2$ , as it should, since in this case the  $N_i$ 's cannot possibly be drawn from these  $n_i$ 's.
- The  $P(\chi^2|v)$  probability function with degree of freedom  $v$  is the probability that the sum of the squares of  $v$  standard Gaussian variables of unit variance and 0 mean will be greater than  $\chi^2$ .
- The terms in the sum of the  $\chi^2$  measure are only good approximations of squares of random standard normal variables when  $N_i \gg 1$  in each bin.
- Usually, the binning process gives a constrained last bin content. Hence, the degree of freedom of  $P(\chi^2|v)$  is only  $v - 1$ !

## Chi-square Test – continue

- Any term  $i$  with  $0 = n_i = N_i$  should be omitted from the sum.
- A term with  $n_i = 0$  and  $N_i \neq 0$  gives an infinite  $\chi^2$ , as it should, since in this case the  $N_i$ 's cannot possibly be drawn from these  $n_i$ 's.
- The  $P(\chi^2|v)$  probability function with degree of freedom  $v$  is the probability that the sum of the squares of  $v$  standard Gaussian variables of unit variance and 0 mean will be greater than  $\chi^2$ .
- The terms in the sum of the  $\chi^2$  measure are only good approximations of squares of random standard normal variables when  $N_i \gg 1$  in each bin.
- Usually, the binning process gives a constrained last bin content. Hence, the degree of freedom of  $P(\chi^2|v)$  is only  $v - 1$ !

## Chi-square Test – continue

- Any term  $i$  with  $0 = n_i = N_i$  should be omitted from the sum.
- A term with  $n_i = 0$  and  $N_i \neq 0$  gives an infinite  $\chi^2$ , as it should, since in this case the  $N_i$ 's cannot possibly be drawn from these  $n_i$ 's.
- The  $P(\chi^2|v)$  probability function with degree of freedom  $v$  is the probability that the sum of the squares of  $v$  standard Gaussian variables of unit variance and 0 mean will be greater than  $\chi^2$ .
- The terms in the sum of the  $\chi^2$  measure are only good approximations of squares of random standard normal variables when  $N_i \gg 1$  in each bin.
- Usually, the binning process gives a constrained last bin content. Hence, the degree of freedom of  $P(\chi^2|v)$  is only  $v - 1$ !

## Chi-square Test – continue

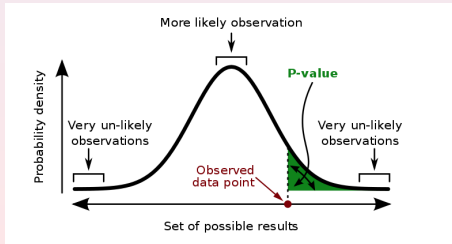
- Any term  $i$  with  $0 = n_i = N_i$  should be omitted from the sum.
- A term with  $n_i = 0$  and  $N_i \neq 0$  gives an infinite  $\chi^2$ , as it should, since in this case the  $N_i$ 's cannot possibly be drawn from these  $n_i$ 's.
- The  $P(\chi^2|v)$  probability function with degree of freedom  $v$  is the probability that the sum of the squares of  $v$  standard Gaussian variables of unit variance and 0 mean will be greater than  $\chi^2$ .
- The terms in the sum of the  $\chi^2$  measure are only good approximations of squares of random standard normal variables when  $N_i \gg 1$  in each bin.
- Usually, the binning process gives a constrained last bin content. Hence, the degree of freedom of  $P(\chi^2|v)$  is only  $v - 1$ !

## Chi-square Test – continue

- Any term  $i$  with  $0 = n_i = N_i$  should be omitted from the sum.
- A term with  $n_i = 0$  and  $N_i \neq 0$  gives an infinite  $\chi^2$ , as it should, since in this case the  $N_i$ 's cannot possibly be drawn from these  $n_i$ 's.
- The  $P(\chi^2|v)$  probability function with degree of freedom  $v$  is the probability that the sum of the squares of  $v$  standard Gaussian variables of unit variance and 0 mean will be greater than  $\chi^2$ .
- The terms in the sum of the  $\chi^2$  measure are only good approximations of squares of random standard normal variables when  $N_i \gg 1$  in each bin.
- Usually, the binning process gives a constrained last bin content. Hence, the degree of freedom of  $P(\chi^2|v)$  is only  $v - 1$ !

# Significance of the *goodness-of-fit* test

- The  $P(\chi^2|v)$  probability function gives via the **p-value** a good estimate for the actual **significance** of the chi-square goodness-of-fit test.
- The **p-value** equals the probability that the Chi-square test may give, under the “*goodness-of-fit*” hypothesis, a result greater or equal than  $x$  :  
$$P(\chi^2|v \geq x) = 1.0 - P(\chi^2|v \leq x).$$
- The higher, resp. the smaller, the  $p$ -value, the more the goodness-of-fit is likely, resp. unlikely.
- If a certain **significance** level is required, like 95% for instance, then the *goodness-of-fit* hypothesis is **rejected** if the  $p$ -value is **smaller** than 5%.



Source : <https://en.wikipedia.org/wiki/P-value>

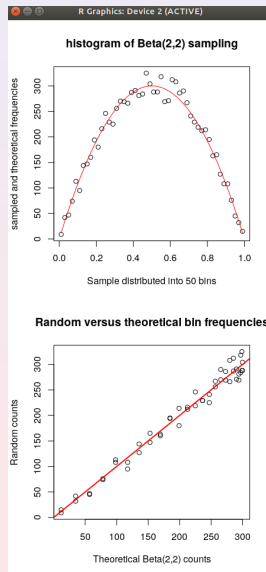


## Exercise (Chi-square "goodness-of-fit" tests)

1. *How to apply a Chi-square "goodness-of-fit" tests to samples taken with a  $B(2, 2)$  random number generator ?*
2. *How to check the accuracy of random sampling from the empirical random law shown on slide 12/34 of lecture 3 ?*
3. *May the random sequences obtained with a Mersenne twister RNG versus the ones obtained from a linear congruational RNG be discriminated by the Chi-square "goodness-of-fit" test ?*
4. *What is the distribution of p-values for samples of size  $n = 10^4$  of uniform random numbers generated with `runif(n)` ?*

# Checking goodness-of-fit of a $B(2, 2)$ sample

```
> par(mfrow=c(2,1))
> nSim = 10^4
> xb = rbeta(nSim,2,2)
> h = hist(xb,breaks=50,plot=F)
> plot(h$mids,h$counts)
> thcounts =
+   dbeta(h$mids,2,2)*0.02*nSim
> lines(h$mids,thcounts,col="red")
> plot(thcounts,h$counts)
> abline(0,1,col="red",lwd=2)
> Ki2=sum((h$counts-thcounts)^2/thcounts)
[1] 46.494
> pval = 1-pchisq(Ki2,length(h$counts)-1)
[1] 0.5753
> chisq.test(h$counts,
+ p=dbeta(h$mids,2,2)*0.02,rescale.p=T)
X-squared = 46.503, df = 49,
p-value = 0.5749
```





## Comparing *two* binned data sets of same size

- Let  $R_i$  be the number of events observed in the  $i$ th bin for the first data set, and let  $S_i$  be the number of events in the same bin for data set two.
- Then the chi-square “*goodness-of-fit*” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(R_i - S_i)^2}{R_i + S_i}$$

where the sum runs over all  $v$  bins.

- If the data were collected in such a way that the sum of  $R_i$ 's is necessarily equal to the sum of the  $S_i$ 's, then the number of degrees of freedom is one less than the number  $v$  of bins.

## Comparing *two* binned data sets of different size

- Let  $R_i$  be the number of events observed in the  $i$ th bin for the first data set, and let  $S_i$  be the number of events in the same bin for data set two.
- Then the chi-square “*goodness-of-fit*” test statistic is :

$$\chi^2 = \sum_{i=1}^v \frac{(\sqrt{S/R} R_i - \sqrt{R/S} S_i)^2}{R_i + S_i}$$

where  $R := \sum_i R_i$  and  $S := \sum_i S_i$ .

- The number of degrees of freedom is still one less than the number  $v$  of bins.

## Problem with small number of counts

- When significant fractions of bins have a small number of counts ( $\leq 10$ , say), then  $\chi^2$  statistics are not well approximated by a chi-square probability function.
- Under the “*goodness-of-fit*” hypothesis, the count in an individual bin,  $N_i$ , is following a Poisson law with  $\lambda = n_i$  and each term  $(N_i - n_i)^2/n_i$  has  $\mu = 1$  and  $\sigma^2 = 2 + 1/n_i$ .
- Each term in the  $\chi^2$  statistic adds, on average, 1 to its value, and slightly more than 2 to its variance.
- But, the variance of the chi-square probability function is exactly twice its mean. If a significant fraction of  $n_i$ 's are small, then quite probable values of the  $\chi^2$  statistic will appear to lie farther out on the tail than they actually are.
- Thus, the “*goodness-of-fit*” hypothesis may be rejected even when it is true.

## Problem with small number of counts

- When significant fractions of bins have a small number of counts ( $\leq 10$ , say), then  $\chi^2$  statistics are not well approximated by a chi-square probability function.
- Under the “*goodness-of-fit*” hypothesis, the count in an individual bin,  $N_i$ , is following a Poisson law with  $\lambda = n_i$  and each term  $(N_i - n_i)^2/n_i$  has  $\mu = 1$  and  $\sigma^2 = 2 + 1/n_i$ .
- Each term in the  $\chi^2$  statistic adds, on average, 1 to its value, and slightly more than 2 to its variance.
- But, the variance of the chi-square probability function is exactly twice its mean. If a significant fraction of  $n_i$ 's are small, then quite probable values of the  $\chi^2$  statistic will appear to lie farther out on the tail than they actually are.
- Thus, the “*goodness-of-fit*” hypothesis may be rejected even when it is true.

## Problem with small number of counts

- When significant fractions of bins have a small number of counts ( $\leq 10$ , say), then  $\chi^2$  statistics are not well approximated by a chi-square probability function.
- Under the “*goodness-of-fit*” hypothesis, the count in an individual bin,  $N_i$ , is following a Poisson law with  $\lambda = n_i$  and each term  $(N_i - n_i)^2/n_i$  has  $\mu = 1$  and  $\sigma^2 = 2 + 1/n_i$ .
- Each term in the  $\chi^2$  statistic adds, on average, 1 to its value, and slightly more than 2 to its variance.
- But, the variance of the chi-square probability function is exactly twice its mean. If a significant fraction of  $n_i$ 's are small, then quite probable values of the  $\chi^2$  statistic will appear to lie farther out on the tail than they actually are.
- Thus, the “*goodness-of-fit*” hypothesis may be rejected even when it is true.

## Problem with small number of counts

- When significant fractions of bins have a small number of counts ( $\leq 10$ , say), then  $\chi^2$  statistics are not well approximated by a chi-square probability function.
- Under the “*goodness-of-fit*” hypothesis, the count in an individual bin,  $N_i$ , is following a Poisson law with  $\lambda = n_i$  and each term  $(N_i - n_i)^2/n_i$  has  $\mu = 1$  and  $\sigma^2 = 2 + 1/n_i$ .
- Each term in the  $\chi^2$  statistic adds, on average, 1 to its value, and slightly more than 2 to its variance.
- But, the variance of the chi-square probability function is exactly twice its mean. If a significant fraction of  $n_i$ ’s are small, then quite probable values of the  $\chi^2$  statistic will appear to lie farther out on the tail than they actually are.
- Thus, the “*goodness-of-fit*” hypothesis may be rejected even when it is true.

## Problem with small number of counts

- When significant fractions of bins have a small number of counts ( $\leq 10$ , say), then  $\chi^2$  statistics are not well approximated by a chi-square probability function.
- Under the “*goodness-of-fit*” hypothesis, the count in an individual bin,  $N_i$ , is following a Poisson law with  $\lambda = n_i$  and each term  $(N_i - n_i)^2/n_i$  has  $\mu = 1$  and  $\sigma^2 = 2 + 1/n_i$ .
- Each term in the  $\chi^2$  statistic adds, on average, 1 to its value, and slightly more than 2 to its variance.
- But, the variance of the chi-square probability function is exactly twice its mean. If a significant fraction of  $n_i$ ’s are small, then quite probable values of the  $\chi^2$  statistic will appear to lie farther out on the tail than they actually are.
- Thus, the “*goodness-of-fit*” hypothesis may be rejected even when it is true.

## Remedies with small number of counts

- Regroup the bins with small number of counts.
- When  $v$ , the number of bins, is large ( $> 30$ ), the central limit theorem implies that the  $\chi^2$  statistic gets approximately a Gaussian distribution :

$$\chi^2 \rightsquigarrow \mathcal{N}\left(v, [2v + \sum_i n_i^{-1}]^{1/2}\right),$$

and  $p$ -values may be computed as a complement of the corresponding cumulated Gaussian distribution function.

- In the case of *two* binned data sets :

$$\sum_i n_i^{-1} \rightarrow \left[ \frac{(R - S)^2}{RS} - 6 \right] \sum_i \frac{1}{R_i + S_i}$$



## Remedies with small number of counts

- Regroup the bins with small number of counts.
- When  $v$ , the number of bins, is large ( $> 30$ ), the central limit theorem implies that the  $\chi^2$  statistic gets approximately a Gaussian distribution :

$$\chi^2 \rightsquigarrow \mathcal{N}\left(v, [2v + \sum_i n_i^{-1}]^{1/2}\right),$$

and  $p$ -values may be computed as a complement of the corresponding cumulated Gaussian distribution function.

- In the case of *two* binned data sets :

$$\sum_i n_i^{-1} \rightarrow \left[ \frac{(R - S)^2}{RS} - 6 \right] \sum_i \frac{1}{R_i + S_i}$$

## Remedies with small number of counts

- Regroup the bins with small number of counts.
- When  $v$ , the number of bins, is large ( $> 30$ ), the central limit theorem implies that the  $\chi^2$  statistic gets approximately a Gaussian distribution :

$$\chi^2 \rightsquigarrow \mathcal{N}\left(v, [2v + \sum_i n_i^{-1}]^{1/2}\right),$$

and  $p$ -values may be computed as a complement of the corresponding cumulated Gaussian distribution function.

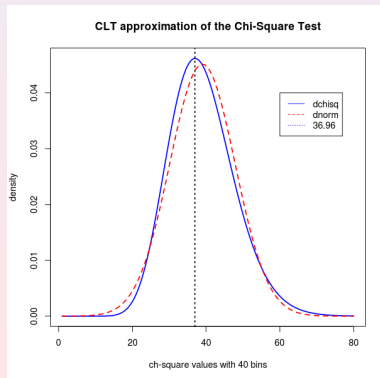
- In the case of *two* binned data sets :

$$\sum_i n_i^{-1} \rightarrow \left[ \frac{(R - S)^2}{RS} - 6 \right] \sum_i \frac{1}{R_i + S_i}$$

## Remedies for small number of counts in R

A  $P(\chi^2|v)$  cdf may be approximated with a Gaussian cdf when  $v > 30$  as shown in R plot below.

```
> breaks = seq(0,1,0.025)
> freq = hist(x,breaks)
> Ni = freq$counts
> epsilon = length(freq$breaks)-1
> ni = rep(Nsim/epsilon,epsilon)
> chi2 = sum((Ni-ni)^2/ni)
[1] 36.96
> df = epsilon - 1
> pvalue = 1.0 - pchisq(chi2,df)
[1] 0.5632565
> sigma = sqrt(2*df+sum(1/ni))
> npvalue = 1.0 -
+       pnorm(chi2,df,sigma)
[1] 0.5912447
```



## RNG Quality : Testing equidistribution

Let  $\langle U_n \rangle = [u_0, u_1, u_2, \dots]$  be a sequence of random numbers from the float interval  $[0.0; 1.0)$  apparently generated in a **uniformly** manner.

To test the quality of the random generator, we consider the auxiliary sequence  $\langle Y_n \rangle = [y_0, y_1, y_2, \dots]$  defined by the rule  $y_n = \lfloor d \times u_n \rfloor$ , where  $d$  is a positive integer – usually 64, 100, or 128 – also called the **discrete grain** of the generator.

When sequence  $\langle U_n \rangle$  is indeed uniformly distributed, we will observe a sequence  $\langle Y_n \rangle$  of **equidistributed** integers between 0 and  $d - 1$ .

The quality of a given random generator may now be assessed with a two-tailed Chi-square “*goodness-of-fit*” test between the empirical  $N_i$  distribution and the theoretical uniform  $n_i = 1/d$  distribution.

A  $p$ -value **below 5%** or **above 95%** indicates the very likeliness of a **suspicious non-randomness** in  $\langle U_n \rangle$ .

## RNG Quality : Serial test

- We reconsider the auxilliary  $\langle Y_n \rangle$  sequence with discrete grain  $d$  and count the number of times the pair  $(y_{2j}, y_{2j+1}) = (q, r)$  occurs, for  $0 \leq j < n/2$ ,  $q \neq r$  and  $0 \leq q, r \leq d$ .
- These counts are to be made for each pair of integers  $(q, r)$  with  $0 \leq q, r \leq d$ , and the Chi-square “goodness-of-fit” test is applied to these  $k = d^2$  categories with theoretical uniform relative frequency  $1/d^2$  in each category.
- To keep the length  $n$  of the random sequence large compared to  $k$ ,  $d$  will be chosen of smaller value than for the equidistributional test.

## RNG Quality : Serial test

- We reconsider the auxiliary  $\langle Y_n \rangle$  sequence with discrete grain  $d$  and count the number of times the pair  $(y_{2j}, y_{2j+1}) = (q, r)$  occurs, for  $0 \leq j < n/2$ ,  $q \neq r$  and  $0 \leq q, r \leq d$ .
- These counts are to be made for each pair of integers  $(q, r)$  with  $0 \leq q, r \leq d$ , and the Chi-square “goodness-of-fit” test is applied to these  $k = d^2$  categories with theoretical uniform relative frequency  $1/d^2$  in each category.
- To keep the length  $n$  of the random sequence large compared to  $k$ ,  $d$  will be chosen of smaller value than for the equidistributional test.

## RNG Quality : Serial test

- We reconsider the auxiliary  $\langle Y_n \rangle$  sequence with discrete grain  $d$  and count the number of times the pair  $(y_{2j}, y_{2j+1}) = (q, r)$  occurs, for  $0 \leq j < n/2$ ,  $q \neq r$  and  $0 \leq q, r \leq d$ .
- These counts are to be made for each pair of integers  $(q, r)$  with  $0 \leq q, r \leq d$ , and the Chi-square “*goodness-of-fit*” test is applied to these  $k = d^2$  categories with theoretical uniform relative frequency  $1/d^2$  in each category.
- To keep the length  $n$  of the random sequence large compared to  $k$ ,  $d$  will be chosen of smaller value than for the equidistributional test.

## RNG Quality : Gap test

- Another test is to examine the length of “gaps” between occurrences of  $u_j$  in a certain range. If  $\alpha$  and  $\beta$  are two real numbers with  $0 \leq \alpha < \beta \leq 1$ , we want to consider the lengths of consecutive subsequences  $[u_j, u_{j+1}, \dots, u_{j+r}]$  in which the consecutive  $r$  values  $u_{j+k}$ , for  $k = 1, \dots, r$ , remain between  $\alpha$  and  $\beta$ . This situation will be counted as a gap of length  $r$ .
- With given values  $\alpha$  and  $\beta$  and a maximal gap length  $t$ , let  $C_r$  for  $r = 0, \dots, t - 1$  count the occurrences of gaps of length  $0, \dots, t - 1$ , and  $C_t$  the gaps of length  $r \geq t$ . If  $p = \beta - \alpha$ , the theoretical counts for each gap length  $r$ , is  $p_r = p(1 - p)^r$  for  $0 \leq r < t - 1$  and  $p_t = (1 - p)^t$ .
- Again, a Chi-square “goodness-of-fit” test, comparing the  $C_r$  with the  $p_r$  distribution may be used in order to assess the likeliness of a suspicious non-randomness of the gap lengths observed in the sequence  $\langle U_n \rangle$ .





## RNG Quality : Gap test

- Another test is to examine the length of “gaps” between occurrences of  $u_j$  in a certain range. If  $\alpha$  and  $\beta$  are two real numbers with  $0 \leq \alpha < \beta \leq 1$ , we want to consider the lengths of consecutive subsequences  $[u_j, u_{j+1}, \dots, u_{j+r}]$  in which the consecutive  $r$  values  $u_{j+k}$ , for  $k = 1, \dots, r$ , remain between  $\alpha$  and  $\beta$ . This situation will be counted as a gap of length  $r$ .
- With given values  $\alpha$  and  $\beta$  and a maximal gap length  $t$ , let  $C_r$  for  $r = 0, \dots, t - 1$  count the occurrences of gaps of length  $0, \dots, t - 1$ , and  $C_t$  the gaps of length  $r \geq t$ . If  $p = \beta - \alpha$ , the theoretical counts for each gap length  $r$ , is  $p_r = p(1 - p)^r$  for  $0 \leq r < t - 1$  and  $p_t = (1 - p)^t$ .
- Again, a Chi-square “goodness-of-fit” test, comparing the  $C_r$  with the  $p_r$  distribution may be used in order to assess the likeliness of a suspicious non-randomness of the gap lengths observed in the sequence  $\langle U_n \rangle$ .

## RNG Quality : Gap test

- Another test is to examine the length of “gaps” between occurrences of  $u_j$  in a certain range. If  $\alpha$  and  $\beta$  are two real numbers with  $0 \leq \alpha < \beta \leq 1$ , we want to consider the lengths of consecutive subsequences  $[u_j, u_{j+1}, \dots, u_{j+r}]$  in which the consecutive  $r$  values  $u_{j+k}$ , for  $k = 1, \dots, r$ , remain between  $\alpha$  and  $\beta$ . This situation will be counted as a gap of length  $r$ .
- With given values  $\alpha$  and  $\beta$  and a maximal gap length  $t$ , let  $C_r$  for  $r = 0, \dots, t - 1$  count the occurrences of gaps of length  $0, \dots, t - 1$ , and  $C_t$  the gaps of length  $r \geq t$ . If  $p = \beta - \alpha$ , the theoretical counts for each gap length  $r$ , is  $p_r = p(1 - p)^r$  for  $0 \leq r < t - 1$  and  $p_t = (1 - p)^t$ .
- Again, a Chi-square “goodness-of-fit” test, comparing the  $C_r$  with the  $p_r$  distribution may be used in order to assess the likeliness of a suspicious non-randomness of the gap lengths observed in the sequence  $\langle U_n \rangle$ .

## RNG Quality : Coupon collector's test

- This test relates the frequency test to the previous gap test. We use the auxiliary sequence  $\langle Y_n \rangle$  and we observe the lengths of subsequences  $y_{j+1}, y_{j+2}, \dots, y_{j+r}$  that are required to get a complete set of integers – a coupon collector segment – from 0 to  $d - 1$ .
- With a given maximal subsequence length  $t$ , let  $C_r$  for  $r = d, \dots, t - 1$  count the occurrences of coupon collector segments of length  $d, d + 1, \dots, t - 1$ , and  $C_t$  the segments of length  $r \geq t$ .
- The theoretical count for each coupon collector segment of length  $r$ , is

$$p_r = \frac{d!}{d^r} \left\{ \begin{matrix} r-1 \\ d-1 \end{matrix} \right\}, \quad d \leq r < t-1; \quad p_t = 1 - \frac{d!}{d^r} \left\{ \begin{matrix} r \\ d \end{matrix} \right\}.$$

- Similarly, a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, may be used in order to assess the likeliness of a suspicious non-randomness of the coupon collector segments.

## RNG Quality : Coupon collector's test

- This test relates the frequency test to the previous gap test. We use the auxiliary sequence  $\langle Y_n \rangle$  and we observe the lengths of subsequences  $y_{j+1}, y_{j+2}, \dots, y_{j+r}$  that are required to get a complete set of integers – a coupon collector segment – from 0 to  $d - 1$ .
- With a given maximal subsequence length  $t$ , let  $C_r$  for  $r = d, \dots, t - 1$  count the occurrences of coupon collector segments of length  $d, d + 1, \dots, t - 1$ , and  $C_t$  the segments of length  $r \geq t$ .
- The theoretical count for each coupon collector segment of length  $r$ , is

$$p_r = \frac{d!}{d^r} \left\{ \begin{matrix} r-1 \\ d-1 \end{matrix} \right\}, \quad d \leq r < t-1; \quad p_t = 1 - \frac{d!}{d^r} \left\{ \begin{matrix} r \\ d \end{matrix} \right\}.$$

- Similarly, a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, may be used in order to assess the likeliness of a suspicious non-randomness of the coupon collector segments.

## RNG Quality : Coupon collector's test

- This test relates the frequency test to the previous gap test. We use the auxiliary sequence  $\langle Y_n \rangle$  and we observe the lengths of subsequences  $y_{j+1}, y_{j+2}, \dots, y_{j+r}$  that are required to get a complete set of integers – a coupon collector segment – from 0 to  $d - 1$ .
- With a given maximal subsequence length  $t$ , let  $C_r$  for  $r = d, \dots, t - 1$  count the occurrences of coupon collector segments of length  $d, d + 1, \dots, t - 1$ , and  $C_t$  the segments of length  $r \geq t$ .
- The theoretical count for each coupon collector segment of length  $r$ , is

$$p_r = \frac{d!}{d^r} \left\{ \frac{r-1}{d-1} \right\}, \quad d \leq r < t-1; \quad p_t = 1 - \frac{d!}{d^r} \left\{ \frac{r}{d} \right\}.$$

- Similarly, a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, may be used in order to assess the likeliness of a suspicious non-randomness of the coupon collector segments.

## RNG Quality : Coupon collector's test

- This test relates the frequency test to the previous gap test. We use the auxiliary sequence  $\langle Y_n \rangle$  and we observe the lengths of subsequences  $y_{j+1}, y_{j+2}, \dots, y_{j+r}$  that are required to get a complete set of integers – a coupon collector segment – from 0 to  $d - 1$ .
- With a given maximal subsequence length  $t$ , let  $C_r$  for  $r = d, \dots, t - 1$  count the occurrences of coupon collector segments of length  $d, d + 1, \dots, t - 1$ , and  $C_t$  the segments of length  $r \geq t$ .
- The theoretical count for each coupon collector segment of length  $r$ , is

$$p_r = \frac{d!}{d^r} \left\{ \frac{r-1}{d-1} \right\}, \quad d \leq r < t-1; \quad p_t = 1 - \frac{d!}{d^r} \left\{ \frac{r}{d} \right\}.$$

- Similarly, a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, may be used in order to assess the likeliness of a suspicious non-randomness of the coupon collector segments.

## RNG Quality : Up and down runs test

- A sequence  $\langle U_n \rangle$  of uniform random numbers may also be tested for “*runs up*” and “*runs down*” segments, by examining the length of monotone portions of it. Let  $[u_{j+0}, u_{j+1}, \dots, u_{j+r}]$  be a subsequence of length  $r$  such that either  $u_{j+0} \geq u_{j+1} \geq \dots \geq u_{j+r}$ , or,  $u_{j+0} \leq u_{j+1} \leq \dots \leq u_{j+r}$ .
- Given a maximal subsequence length  $t$ , let  $C_r$  for  $r = 1, \dots, t - 1$  count the occurrences of separated monotone, either up, or, down runs of length  $1, 2, \dots, t - 1$ , and  $C_t$  the same runs of length  $r \geq t$ .
- Assuming that a monotone run of length  $r$  occurs with probability  $1/r! - 1/(r+1)!$ , the theoretical relative count for each length  $r$ , gives  $p_r = 1/r! - 1/(r+1)!$  for  $r < t$  and  $p_t = 1/t!$ .
- And, again, we may use a Chi-square “*goodness-of-fit*” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, for assessing the likeliness of a suspicious non-randomness of “*runs up*” or “*runs down*” segments.

## RNG Quality : Up and down runs test

- A sequence  $\langle U_n \rangle$  of uniform random numbers may also be tested for “runs up” and “runs down” segments, by examining the length of monotone portions of it. Let  $[u_{j+0}, u_{j+1}, \dots, u_{j+r}]$  be a subsequence of length  $r$  such that either  $u_{j+0} \geq u_{j+1} \geq \dots \geq u_{j+r}$ , or,  $u_{j+0} \leq u_{j+1} \leq \dots \leq u_{j+r}$ .
- Given a maximal subsequence length  $t$ , let  $C_r$  for  $r = 1, \dots, t - 1$  count the occurrences of separated monotone, either up, or, down runs of length  $1, 2, \dots, t - 1$ , and  $C_t$  the same runs of length  $r \geq t$ .
- Assuming that a monotone run of length  $r$  occurs with probability  $1/r! - 1/(r+1)!$ , the theoretical relative count for each length  $r$ , gives  $p_r = 1/r! - 1/(r+1)!$  for  $r < t$  and  $p_t = 1/t!$ .
- And, again, we may use a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, for assessing the likeliness of a suspicious non-randomness of “runs up” or “runs down” segments.



## RNG Quality : Up and down runs test

- A sequence  $\langle U_n \rangle$  of uniform random numbers may also be tested for “runs up” and “runs down” segments, by examining the length of monotone portions of it. Let  $[u_{j+0}, u_{j+1}, \dots, u_{j+r}]$  be a subsequence of length  $r$  such that either  $u_{j+0} \geq u_{j+1} \geq \dots \geq u_{j+r}$ , or,  $u_{j+0} \leq u_{j+1} \leq \dots \leq u_{j+r}$ .
- Given a maximal subsequence length  $t$ , let  $C_r$  for  $r = 1, \dots, t - 1$  count the occurrences of separated monotone, either up, or, down runs of length  $1, 2, \dots, t - 1$ , and  $C_t$  the same runs of length  $r \geq t$ .
- Assuming that a monotone run of length  $r$  occurs with probability  $1/r! - 1/(r+1)!$ , the theoretical relative count for each length  $r$ , gives  $p_r = 1/r! - 1/(r+1)!$  for  $r < t$  and  $p_t = 1/t!$ .
- And, again, we may use a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, for assessing the likeliness of a suspicious non-randomness of “runs up” or “runs down” segments.

## RNG Quality : Up and down runs test

- A sequence  $\langle U_n \rangle$  of uniform random numbers may also be tested for “runs up” and “runs down” segments, by examining the length of monotone portions of it. Let  $[u_{j+0}, u_{j+1}, \dots, u_{j+r}]$  be a subsequence of length  $r$  such that either  $u_{j+0} \geq u_{j+1} \geq \dots \geq u_{j+r}$ , or,  $u_{j+0} \leq u_{j+1} \leq \dots \leq u_{j+r}$ .
- Given a maximal subsequence length  $t$ , let  $C_r$  for  $r = 1, \dots, t - 1$  count the occurrences of separated monotone, either up, or, down runs of length  $1, 2, \dots, t - 1$ , and  $C_t$  the same runs of length  $r \geq t$ .
- Assuming that a monotone run of length  $r$  occurs with probability  $1/r! - 1/(r+1)!$ , the theoretical relative count for each length  $r$ , gives  $p_r = 1/r! - 1/(r+1)!$  for  $r < t$  and  $p_t = 1/t!$ .
- And, again, we may use a Chi-square “goodness-of-fit” test, comparing the empirical  $C_r$  with the theoretical  $p_r$  distribution, for assessing the likeliness of a suspicious non-randomness of “runs up” or “runs down” segments.

## 1. Methodology

Comparing statistical distributions

Methodological approach

Statistical tests

## 2. Comparing histograms

Chi-square test against a known distribution

Comparing two binned data sets

Testing uniform randomness

## 3. Comparing continuous distributions

Kolmogorov-Smirnov Test

Kolmogorov-Smirnov Test in R

## Kolmogorov-Smirnov Test

- The ordered list of data points is converted into a cumulative distribution function of the probability distribution from which it has been drawn.
- If the  $N$  events are located at points  $x_i$ ,  $i = 1, \dots, N$ , then  $S_N(x)$  is giving the fraction of points to the left of a given value  $x$ .
- The Kolmogorov-Smirnov statistic  $D$  is defined as the maximum value of the absolute difference between two cumulative distribution functions.
- When comparing  $S_N(x)$  to a known cdf  $P(x)$ , the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_N(x) - P(x)|$$

- For comparing two different cdf's, the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_{N_1}(x) - S_{N_2}(x)|$$

## Kolmogorov-Smirnov Test

- The ordered list of data points is converted into a cumulative distribution function of the probability distribution from which it has been drawn.
- If the  $N$  events are located at points  $x_i$ ,  $i = 1, \dots, N$ , then  $S_N(x)$  is giving the fraction of points to the left of a given value  $x$ .
- The Kolmogorov-Smirnov statistic  $D$  is defined as the maximum value of the absolute difference between two cumulative distribution functions.
- When comparing  $S_N(x)$  to a known cdf  $P(x)$ , the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_N(x) - P(x)|$$

- For comparing two different cdf's, the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_{N_1}(x) - S_{N_2}(x)|$$

## Kolmogorov-Smirnov Test

- The ordered list of data points is converted into a cumulative distribution function of the probability distribution from which it has been drawn.
- If the  $N$  events are located at points  $x_i$ ,  $i = 1, \dots, N$ , then  $S_N(x)$  is giving the fraction of points to the left of a given value  $x$ .
- The Kolmogorov-Smirnov statistic  $D$  is defined as the maximum value of the absolute difference between two cumulative distribution functions.
- When comparing  $S_N(x)$  to a known cdf  $P(x)$ , the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_N(x) - P(x)|$$

- For comparing two different cdf's, the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_{N_1}(x) - S_{N_2}(x)|$$

## Kolmogorov-Smirnov Test

- The ordered list of data points is converted into a cumulative distribution function of the probability distribution from which it has been drawn.
- If the  $N$  events are located at points  $x_i$ ,  $i = 1, \dots, N$ , then  $S_N(x)$  is giving the fraction of points to the left of a given value  $x$ .
- The Kolmogorov-Smirnov statistic  $D$  is defined as the maximum value of the absolute difference between two cumulative distribution functions.
- When comparing  $S_N(x)$  to a known cdf  $P(x)$ , the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_N(x) - P(x)|$$

- For comparing two different cdf's, the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_{N_1}(x) - S_{N_2}(x)|$$

## Kolmogorov-Smirnov Test

- The ordered list of data points is converted into a cumulative distribution function of the probability distribution from which it has been drawn.
- If the  $N$  events are located at points  $x_i$ ,  $i = 1, \dots, N$ , then  $S_N(x)$  is giving the fraction of points to the left of a given value  $x$ .
- The Kolmogorov-Smirnov statistic  $D$  is defined as the maximum value of the absolute difference between two cumulative distribution functions.
- When comparing  $S_N(x)$  to a known cdf  $P(x)$ , the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_N(x) - P(x)|$$

- For comparing two different cdf's, the K-S statistic is

$$D = \max_{-\infty < x < +\infty} |S_{N_1}(x) - S_{N_2}(x)|$$



## Kolmogorov-Smirnov Test – continue

- Testing the p-value significance of the K-S test is done with the complement  $Q_{KS}(z) = 1 - P_{KS}(z)$  of the cdf  $P_{KS}(z)$  of the K-S distribution for  $z > 0$  :

$$P_{KS}(z) = 1 - 2 \sum_{j=1}^{\infty} (-1)^{j-1} \exp(-2j^2 z^2)$$

- The K-S statistic is invariant under reparametrization of the data set points.  $D$  remains the same when locally stretching and sliding the  $x$  axis. Using for instance  $x$  or  $\log x$  in  $D$  will result in the same significance of the test.

## Kolmogorov-Smirnov Test – continue

- Testing the p-value significance of the K-S test is done with the complement  $Q_{KS}(z) = 1 - P_{KS}(z)$  of the cdf  $P_{KS}(z)$  of the K-S distribution for  $z > 0$  :

$$P_{KS}(z) = 1 - 2 \sum_{j=1}^{\infty} (-1)^{j-1} \exp(-2j^2 z^2)$$

- The K-S statistic is invariant under reparametrization of the data set points.  $D$  remains the same when locally stretching and sliding the  $x$  axis. Using for instance  $x$  or  $\log x$  in  $D$  will result in the same significance of the test.

## Kolmogorov-Smirnov Test in R

- The  $D$  observed and its  $p$ -value as disproof of the null hypothesis that the distributions under review are the same is given by the R `ks.test` procedure.

```
> x = rnorm(50)
> ks.test(x,"pnorm")
  D = 0.101, p-value = 0.6498
> y = runif(30,-2.5,2.5)
> plot(ecdf(x),col="blue")
> plot(ecdf(y),add=T,col="red")
> ks.test(x,y,exact=T)
  D = 0.3267, p-value = 0.02926
```

